

### 750 kHz Boost Controller

#### **Features**

- · Output Power Capability Over 5 Watts
- Output Voltage Capability From 3.3V to Over 100V
- 750 kHz Gated Oscillator Switching Frequency
- Adaptable Duty Cycle for Battery or Wide-Input, Voltage-Range Applications
- · Input Voltage Range: 2.0V to 5.5V
- · Capable of SEPIC and Flyback Topologies
- Shutdown Control with I<sub>Q</sub> < 0.1 μA (Typical)</li>
- Low Operating Quiescent Current: I<sub>Q</sub> = 120 μA
- · Voltage Feedback Tolerance (0.6%, Typical)
- Popular MSOP-8 Package
- · Peak Current Limit Feature
- Two Undervoltage Lockout (UVLO) Options:
  - 2.0V or 2.55V
- Operating Temperature Range: -40°C to +125°C

#### **Applications**

- · High-Power Boost Applications
- · High-Voltage Bias Supplies
- · White LED Drivers and Flashlights
- · Local 3.3V to 5.0V Supplies
- · Local 3.3V to 12V Supplies
- · Local 5.0V to 12V Supplies
- · LCD Bias Supply

#### Description

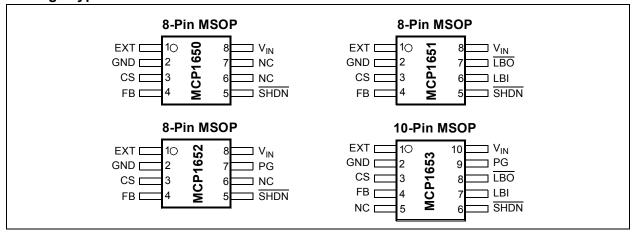
The MCP1650/51/52/53 is a 750 kHz gated oscillator boost controller packaged in an 8 or 10-pin MSOP package. Developed for high-power, portable applications, the gated oscillator controller can deliver 5 watts of power to the load while consuming only 120  $\mu A$  of quiescent current at no load. The MCP1650/51/52/53 can operate over a wide input voltage range (2.0V to 5.5V) to accommodate multiple primary-cell and single-cell Li-lon battery-powered applications, in addition to 2.8V, 3.3V and 5.0V regulated input voltages.

An internal 750 kHz gated oscillator makes the MCP1650/51/52/53 ideal for space-limited designs. The high switching frequency minimizes the size of the external inductor and capacitor, saving board space and cost. The internal oscillator operates at two different duty cycles depending on the level of the input voltage. By changing duty cycle in this fashion, the peak input current is reduced at high input voltages, reducing output ripple voltage and electrical stress on power train components. When the input voltage is low, the duty cycle changes to a larger value in order to provide full-power capability at a wide input voltage range typical of battery-powered, portable applications.

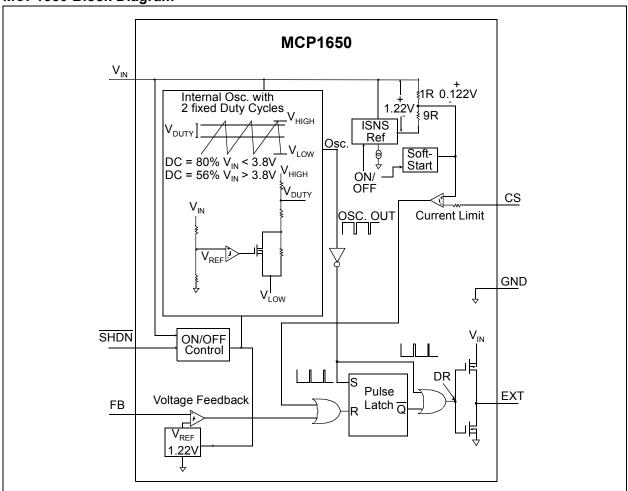
The MCP1650/51/52/53 was designed to drive external switches directly using internal low-resistance MOSFETs.

Additional features integrated on the MCP1650/51/52/53 family include peak input current limit, adjustable output voltage/current, low battery detection and power-good indication.

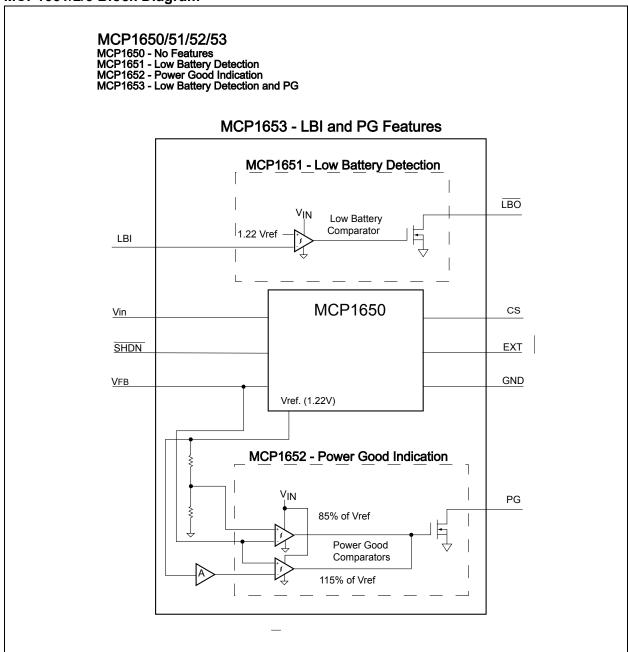
#### **Package Types**



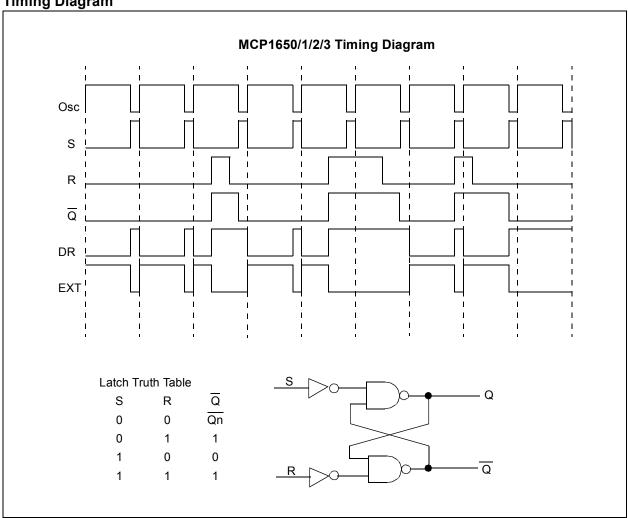
### MCP1650 Block Diagram



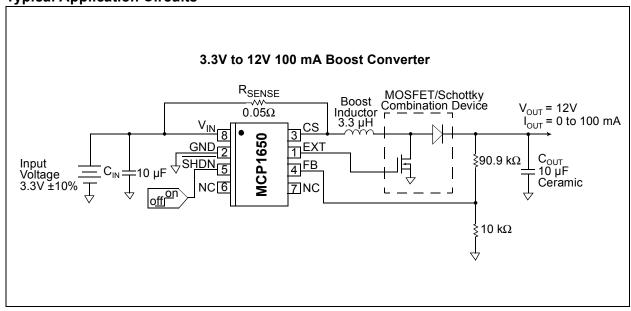
### MCP1651/2/3 Block Diagram







#### **Typical Application Circuits**



# 1.0 ELECTRICAL CHARACTERISTICS

#### **Absolute Maximum Ratings †**

V <sub>IN</sub> TO GND	6.0V
CS,FB,LBI, LBO, SHDN, PG, EXT	GND – 0.3V to
	$V_{IN} + 0.3V$
Current at EXT pin	±1A
Storage temperature	65°C to +150°C
Operating Junction Temperature	40°C to +125°C
ESD protection on all pins	≥ 4 kV HBM

† Notice: Stresses above those listed under "Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

#### DC CHARACTERISTICS

**Electrical Specifications:** Unless otherwise noted, all parameters apply at  $V_{IN}$  = +2.7V to +5.5V,  $\overline{SHDN}$  = High,  $T_J$  = -40°C to +125°C. Typical values apply for  $V_{IN}$  = 3.3V,  $T_A$  +25°C.

Parameters	Sym	Min	Тур	Max	Units	Conditions
Input Characteristics					•	•
Supply Voltage	V <sub>IN</sub>	2.7	_	5.5	V	
Undervoltage Lockout (S Option)	UVLO	2.4	2.55	2.7	V	V <sub>IN</sub> rising edge
Under Voltage Lockout (R Option)	UVLO	1.85	2.0	2.15	V	V <sub>IN</sub> rising edge
Undervoltage Hysteresis	UVLO <sub>HYST</sub>		117		mV	
Shutdown Supply Current	I <sub>SHD</sub>		0.001	1	μA	SHDN = GND
Quiescent Supply Current	IQ		120	220	μA	EXT = Open
Soft Start Time	T <sub>SS</sub>		500		μs	
Feedback Characteristics						
Feedback Voltage	V <sub>FB</sub>	1.18	1.22	1.26	V	All conditions
Feedback Comparator Hysteresis	V <sub>HYS</sub>	_	12	23	mV	
Feedback Input Bias Current	I <sub>FBIk</sub>	-50	_	50	nA	V <sub>FB</sub> < 1.3V
Current Sense Input						•
Current Sense Threshold	I <sub>SNS-TH</sub>	75	114	155	mV	
Delay from Current Sense to Output	T <sub>dly_ISNS</sub>	_	80	_	ns	
Ext Drive						
EXT Driver ON Resistance (High Side)	R <sub>HIGH</sub>	_	8	18	Ω	
EXT Driver ON Resistance (Low Side)	R <sub>LOW</sub>	_	4	12	Ω	
Oscillator Characteristics						
Switching Frequency	Fosc	650	750	850	kHz	
Low Duty Cycle Switch-Over Voltage	V <sub>LowDuty</sub>	_	3.8	_	V	V <sub>IN</sub> rising edge
Duty Cycle Switch Voltage Hysteresis	DC <sub>Hyst</sub>	-	92		mV	
Low Duty Cycle	DC <sub>LOW</sub>	50	56	62	%	
High Duty Cycle	DC <sub>HIGH</sub>	72	80	88	%	

## DC CHARACTERISTICS (CONTINUED)

**Electrical Specifications:** Unless otherwise noted, all parameters apply at  $V_{IN} = +2.7V$  to +5.5V,  $\overline{SHDN} = High$ ,  $T_J = -40^{\circ}C$  to  $+125^{\circ}C$ . Typical values apply for  $V_{IN} = 3.3V$ ,  $T_A + 25^{\circ}C$ .

$T_J$ = -40°C to +125°C. Typical values apply for $V_{IN}$ = 3.3V, $T_A$ +25°C.									
Parameters	Sym	Min	Тур	Max	Units	Conditions			
Shutdown Input									
Logic High Input	V <sub>IN-HIGH</sub>	50	_	_	% of V <sub>IN</sub>				
Logic Low Input	V <sub>IN-Low</sub>		_	15	% of V <sub>IN</sub>				
Input Leakage Current	ISHDN		5	100	nA	SHDN=V <sub>IN</sub>			
Low Battery Detect (MCP1651	/MCP1653 Or	nly)							
Low Battery Threshold	LBI <sub>TH</sub>	1.18	1.22	1.26	V	LBI Input falling (All Conditions)			
Low Battery Threshold Hysteresis	LBI <sub>THHYS</sub>	95	123	145	mV				
Low Battery Input Leakage Current	I <sub>LBI</sub>		10	_	nA	V <sub>LBI</sub> = 2.5V			
Low Battery Output Voltage	V <sub>LBO</sub>	_	53	200	mV	$I_{LB}$ SINK = 3.2 mA, $V_{LBI}$ = 0V			
Low Battery Output Leakage Current	I <sub>LBO</sub>	_	0.01	1	μA	$V_{LBI} = 5.5V$ , $V_{\overline{LBO}} = 5.5V$			
Time Delay from LBI to LBO	T <sub>D_LBO</sub>		70	_	μs	L <sub>BI</sub> Transitions from L <sub>BITH</sub> + 0.1V to L <sub>BITH</sub> - 0.1V			
Power Good Output (MCP165	2/MCP1653 O	nly)							
Power Good Threshold Low	V <sub>PGTH-L</sub>	-20	-15	-10	%	Referenced to Feedback Voltage			
Power Good Threshold High	V <sub>PGTH-H</sub>	+10	+15	+20	%	Referenced to Feedback Voltage			
Power Good Threshold Hysteresis	V <sub>PGTH-HYS</sub>		5	_	%	Referenced to Feedback Voltage (Both Low and High Thresholds)			
Power Good Output Voltage	V <sub>PGOUT</sub>	_	53	200	mV	$I_{PG}$ SINK = 3.2 mA, $V_{FB}$ = 0V			
Time Delay from V <sub>FB</sub> out of regulation to Power Good Output transition	T <sub>D_PG</sub>		85	_	μs	V <sub>FB</sub> Transitions from V <sub>FBTH</sub> + 0.1V to V <sub>FBTH</sub> -0.1V			

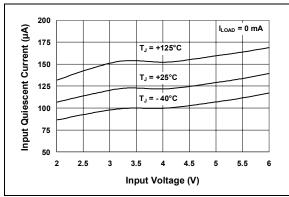
#### **TEMPERATURE SPECIFICATIONS**

**Electrical Specifications**: Unless otherwise noted, all parameters apply at  $V_{IN} = +2.7V$  to +5.5V,  $\overline{SHDN} = High$ ,  $T_A = -40^{\circ}C$  to  $+125^{\circ}C$ . Typical values apply for  $V_{IN} = 3.3V$ .  $T_A = +25^{\circ}C$ .

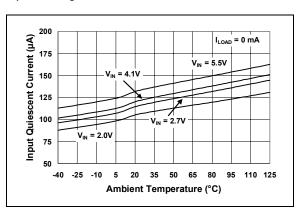
$I_A = -40^{\circ}\text{C}$ to +125 °C. Typical values apply for $V_{\text{IN}} = 3.3 \text{V}$ , $I_A = +25 ^{\circ}\text{C}$ .								
Parameters	Sym	Min	Тур	Max	Units	Conditions		
Temperature Ranges								
Storage Temperature Range	T <sub>A</sub>	-40	_	+125	°C			
Operating Junction Temperature Range	T <sub>J</sub>	-40	_	+125	°C	Continuous		
Thermal Package Resistances								
Thermal Resistance, MSOP-8	$\theta_{JA}$	_	208	_	°C/W	Single-Layer SEMI G42-88 Board, Natural Convection		
Thermal Resistance, MSOP-10	$\theta_{JA}$	_	113	_	°C/W	4-Layer JC51-7 Standard Board, Natural Convection		

#### 2.0 TYPICAL PERFORMANCE CURVES

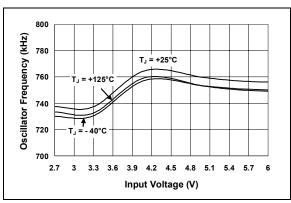
**Note:** The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.



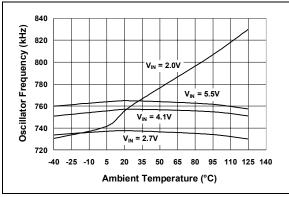
**FIGURE 2-1:** Input Quiescent Current vs. Input Voltage.



**FIGURE 2-2:** Input Quiescent Current vs. Ambient Temperature.



**FIGURE 2-3:** Oscillator Frequency vs. Input Voltage.



**FIGURE 2-4:** Oscillator Frequency vs. Ambient Temperature.

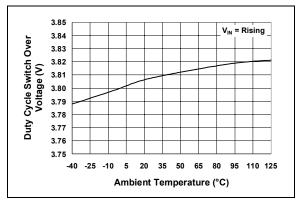


FIGURE 2-5: Duty Cycle Switch-Over Voltage vs. Ambient Temperature.

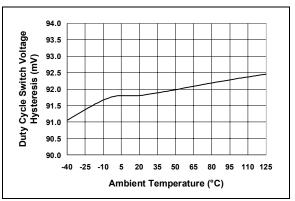


FIGURE 2-6: Duty Cycle Switch-Over Hysteresis Voltage vs. Ambient Temperature.

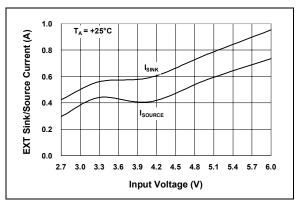
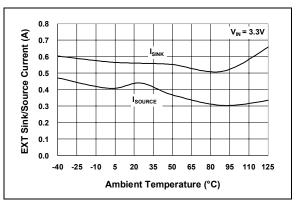
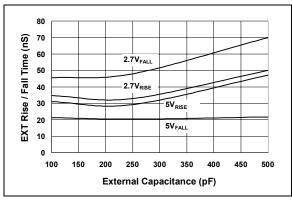


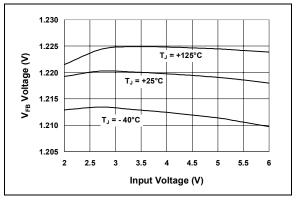
FIGURE 2-7: EXT Sink and Source Current vs. Input Voltage.



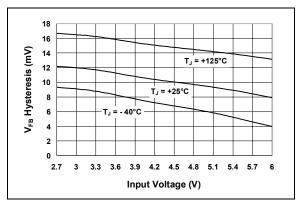
**FIGURE 2-8:** EXT Sink and Source Current vs. Ambient Temperature.



**FIGURE 2-9:** EXT Rise and Fall Times vs. External Capacitance.



**FIGURE 2-10:** Feedback Voltage vs. Input Voltage.



**FIGURE 2-11:** Feedback Voltage Hysteresis vs. Input Voltage.

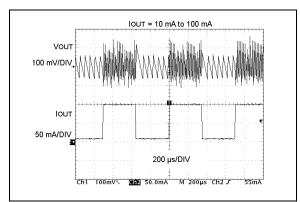


FIGURE 2-12: Dynamic Load Response.

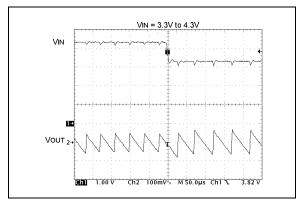
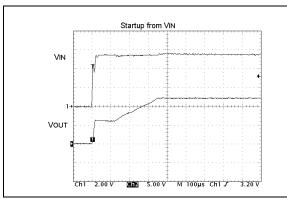


FIGURE 2-13: Dynamic Line Response.



**FIGURE 2-14:** Power-Up Timing (Input Voltage).

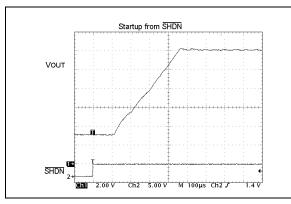


FIGURE 2-15: Power-Up Timing (Shutdown).

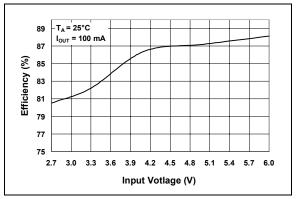


FIGURE 2-16: Efficiency vs. Input Voltage.

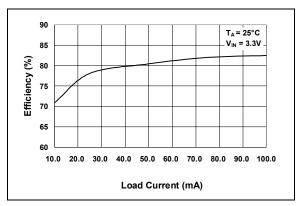
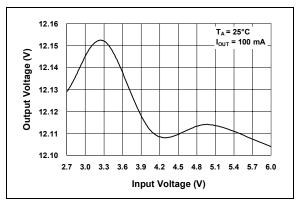
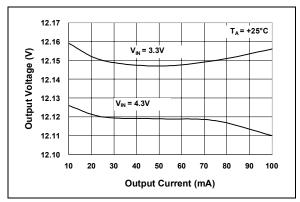


FIGURE 2-17: Efficiency vs. Load Current.



**FIGURE 2-18:** Output Voltage vs. Input Voltage (Line Regulation).



**FIGURE 2-19:** Output Voltage vs. Output Current (Load Regulation).

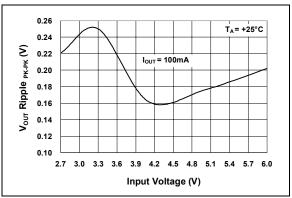


FIGURE 2-20: Output Voltage Ripple vs. Input Voltage.

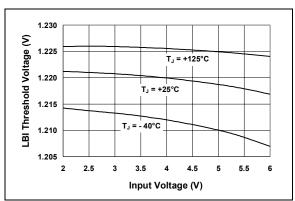


FIGURE 2-21: LBI Threshold Voltage vs. Input Voltage.

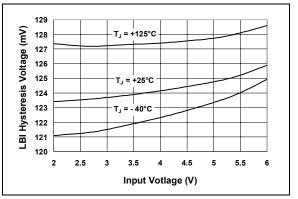


FIGURE 2-22: LBI Hysteresis Voltage vs. Input Voltage.

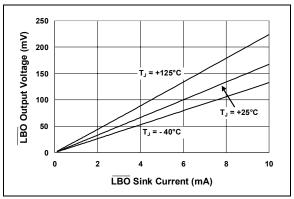


FIGURE 2-23: LBO Output Voltage vs. LBO Sink Current.

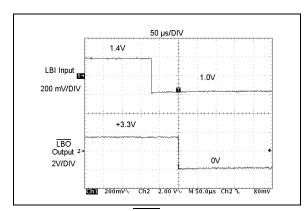
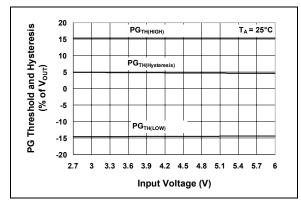
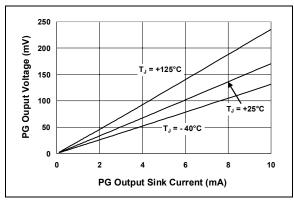


FIGURE 2-24: LBO Output Timing.



**FIGURE 2-25:** PG Threshold and Hysteresis Percentage vs. Input Voltage.



**FIGURE 2-26:** PG Output Voltage vs. Sink Current.

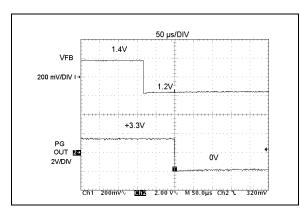
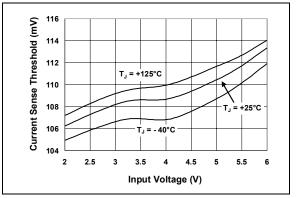
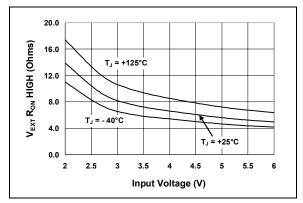


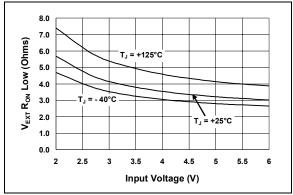
FIGURE 2-27: PG Timing.



**FIGURE 2-28:** Current Sense Threshold vs. Input Voltage.



**FIGURE 2-29:**  $V_{EXT}$  High Output Voltage vs. Input Voltage.



**FIGURE 2-30:** V<sub>EX</sub>: vs. Input Voltage.

V<sub>EXT</sub> Low Output Voltage

#### 3.0 PIN DESCRIPTIONS

The descriptions of the pins are listed in Table 3-1.

TABLE 3-1: PIN FUNCTION TABLE

Pin No. MCP1650	Pin No. MCP1651	Pin No. MCP1652	Pin No. MCP1653	Symbol	Function
1	1	1	1	EXT	External Gate Drive
2	2	2	2	GND	Ground
3	3	3	3	CS	Current Sense
4	4	4	4	FB	Feedback Input
5	5	5	6	SHDN	Shutdown
_	6	_	7	LBI	Low Battery Input
_	7	_	8	LBO	Low Battery Output
_	_	7	9	PG	Power Good Output
8	8	8	10	$V_{IN}$	Input Voltage

### 3.1 External Gate Drive (EXT)

EXT is the output pin that drives the external N-channel MOSFET on and off during boost operation. EXT is equal to GND for SHDN or UVLO conditions.

#### 3.2 Circuit Ground (GND)

Connect the GND pin to circuit ground. See layout guidelines for suggested grounding physical layout.

#### 3.3 Current Sense (CS)

Input peak current is sensed on CS through the external current sense resistor. When the sensed current is converted to a voltage, the current sense threshold is 122 mV below  $V_{\mbox{\scriptsize IN}}$  typical. If that threshold is exceeded, the pulse is terminated asynchronously.

#### 3.4 Feedback Input (FB)

Connect output voltage of boost converter through external resistor divider to the FB pin for voltage regulation. The nominal voltage that is compared to this input for pulse termination is 1.22V.

## 3.5 Shutdown Input (SHDN)

The  $\overline{SHDN}$  input is used to turn the boost converter on and off. For normal operation, tie this pin high or to  $V_{IN}$ . To turn off the device, tie this pin to low or ground.

#### 3.6 Low Battery Input (LBI)

LBI is the input pin for the low battery comparator. When the voltage on this pin falls below the nominal 1.22V threshold setting, the LBO (Low Battery Output) open-drain is active-low.

### 3.7 Low Battery Output (LBO)

LBO is an active-low, open-drain output capable of sinking 10 mA when the LBI pin is below the threshold voltage. LBO is high-impedance during SHDN or UVLO conditions.

#### 3.8 Power Good (PG)

PG is an active-high, open-drain output capable of sinking 10 mA when the FB input pin is 15% below its typical value or more than 15% above its typical value, indicating that the output voltage is out of regulation. PG is high impedance during SHDN or UVLO condition.

#### 3.9 Input Voltage (V<sub>IN</sub>)

 $V_{\text{IN}}$  is an input supply pin. Tie 2.7V to 5.5V input power source.

#### 4.0 DETAILED DESCRIPTION

#### 4.1 Device Overview

The MCP1650/51/52/53 is a gated oscillator boost controller. By adding an external N-channel MOSFET, schottky diode and boost inductor, high-output power applications can be achieved. The 750 kHz hysteretic gated oscillator architecture enables the use of small, low-cost external components. By using a hysteretic approach, no compensation components are necessary for the stability of the regulator output.

Output voltage regulation is accomplished by comparing the output voltage (sensed through an external resistor divider) to a reference internal to the MCP1650/51/52/53. When the sensed output voltage is below the reference, the EXT pin pulses the external N-channel MOSFET on and off at the 750 kHz gated oscillator frequency. Energy is stored in the boost inductor when the external N-channel MOSFET is on and is delivered to the load through the external Schottky diode when the MOSFET is turned off. Several pulses may be required to deliver enough energy to pump the output voltage above the upper hysteretic limit. Once above the hysteretic limit, the internal oscillator is no longer gated to the EXT pin and no energy is transferred from input to output.

The peak current in the MOSFET is sensed to limit its maximum value. As with all boost topology converters, even though the MOSFET is turned off, there is still a DC path through the boost inductor and diode to the load. Additional protection circuity, such as fuses, are recommended for short circuit protection.

#### 4.2 Input Voltage

The range of input voltage for the MCP1650/51/52/53 family of devices is specified from 2.7V to 5.5V. For the S-option devices, the undervoltage lockout (UVLO) feature will turn the boost controller off once the input voltage falls below 2.55V, typical. For the R-option devices, the UVLO is set to 2.0V. The R-option devices are recommended for use when "bootstrapping" the output voltage back to the input. The input of the MCP1650/51/52/53 device is supplied by the output voltage during boost operation. This can be used to derive output voltages from input voltages that start up at approximately 2V (2-cell alkaline batteries).

#### 4.3 Fixed Duty Cycle

The MCP1650/51/52/53 family utilizes a unique two-step maximum duty cycle architecture to minimize input peak current and improve output ripple voltage for wide input voltage operating ranges. When the input voltage is below 3.8V, the duty cycle is typically 80%. For input voltages above 3.8V, the duty cycle is typically 56%. By decreasing the duty cycle at higher input voltages, the input peak current is reduced. For low input voltages, a longer duty cycle stores more energy during the ontime of the boost MOSFET. For applications that span the 3.8V input range, the inductor value should be selected to meet not only the minimum input voltage at 80% duty cycle, but 3.8V at 56% duty cycle as well. Refer to **Section 5.0 "Application Circuits/Issues"** for more information about selecting inductor values.

#### 4.4 Shutdown Input Operation

The SHDN pin is used to turn the MCP1650/51/52/53 on and off. When the SHDN pin is tied low, the MCP1650/51/52/53 is off. When tied high, the MCP1650/51/52/53 will be enabled and begin boost operation as long as the input voltage is not below the UVLO threshold.

#### 4.5 Soft-Start Operation

When power is first applied to the MCP1650/51/52/53, the internal reference initialization is controlled to slow down the start-up of the boost output voltage. This is done to reduce high inrush current required from the source. High inrush currents can cause the source voltage to drop suddenly and trip the UVLO threshold, shutting down the converter prior to it reaching steady-state operation.

#### 4.6 Gated Oscillator Architecture

A 750 kHz internal oscillator is used as the base frequency of the MCP1650/51/52/53. The oscillator duty cycle is typically 80% when the input voltage is below a nominal value of 3.8V, and 56% when the input voltage is above a nominal value of 3.8V. Two duty cycles are provided to reduce the peak inductor current in applications where the input voltage varies over a wide range. High-peak inductor current results in undesirable high-output ripple voltages. For applications that have input voltage that cross this 3.8V boundary, both duty cycle conditions need to be examined to determine which one has the least amount of energy storage. Refer to **Section 5.0** "Application Circuits/Issues" for more information about design considerations.

#### 4.7 FB Pin

The output voltage is fed back through a resistor divider to the FB pin. It is then compared to an internal 1.22V reference. When the divided-down output is below the internal reference, the internal oscillator is gated on and the EXT pin pulses the external N-channel MOSFET on and off to transfer energy from the source to the load at 750 kHz. This will cause the output voltage to rise until it is above the 1.22V threshold, thereby gating the internal oscillator off. Hysteresis is provided within the comparator and is typically 12 mV. The rate at which the oscillator is gated on and off is determined by the input voltage, load current, hysteresis voltage and inductance. The output ripple voltage will vary depending on the input voltage, load current, hysteresis voltage and inductance.

#### 4.8 PWM Latch

The gated oscillator is self-latched to prevent double and sporadic pulsing. The reset into the latch is asynchronous and can terminate the pulse during the ontime of the duty cycle. The reset can be accomplished by the feedback voltage comparator or the current limit comparator.

#### 4.9 Peak Inductor Current

The external switch peak current is sensed on the CS pin across an optional external current sense resistor. If the CS pin falls more than 122 mV (typical) below  $V_{IN}$ , the current limit comparator is set and the pulse is terminated. This prevents the current from getting too high and damaging the N-channel MOSFET. In the event of a short circuit, the switch current will be low due to the current limit. However, there is a DC path from the input through the inductor and external diode. This is true for all boost-derived topologies and additional protection circuitry is necessary to prevent catastrophic damage.

#### 4.10 EXT Output Driver

The EXT output pin is designed to directly drive external N-channel MOSFETs and is capable of sourcing 400 mA (typical) and sinking 800 mA (typical) for fast on and off transitions. The top side of the EXT driver is connected directly to  $V_{\rm IN}$ , while the low side of the driver is tied to GND, providing rail-to-rail drive capability. Design flexibility is added by connecting an external resistor in series with the N-channel MOSFET to control the speed of the turn on and off. By slowing the transition speed down, there will be less high-frequency noise. Speeding the transition up produces higher efficiency.

#### 4.11 Low Battery Detect

The Low-Battery Detect (MCP1651 and MCP1653 only) feature can be used to determine when the LBI input voltage has fallen below a predetermined threshold. The low-battery detect comparator continuously monitors the voltage on the LBI pin. When the voltage on the LBI pin is above the 1.22V + 123 mV hysteresis, the LBO pin will be high-impedance (opendrain). When in the high-impedance state, the leakage current into the LBO pin is typically less than 0.1 µA. As the voltage on the LBI pin decreases and is lower than the 1.22V typical threshold, the LBO pin will transition to a low state and is capable of sinking up to 10 mA. 123 mV of hysteresis is provided to prevent chattering of the LBO pin as a result of battery input impedance and boost input current.

#### 4.12 Power Good Output

The Power Good Output feature (MCP1652 and MCP1653 only) monitors the divided-down voltage feedback into the FB pin. When the output voltage falls more than 15% (typical) below the regulated set point, the power good (PG) output pin will transition from a high-impedance state (open-drain) to a low state capable of sinking 10 mA. If the output voltage rises more than 15% (typical) above the regulated set point, the PG output pin will transition from high to low.

#### 4.13 Device Protection

#### 4.13.1 OVERCURRENT LIMIT

The Current Sense (CS) input pin is used to sense the peak input current of the boost converter. This can be used to limit how high the peak inductor current can reach. The current sense feature is optional and can be bypassed by connecting the  $V_{\text{IN}}$  input pin to the CS input pin. Because of the path from input through the boost inductor and boost diode to output, the boost topology cannot support a short circuit without additional circuitry. This is typical of all boost regulators.

### 5.0 APPLICATION CIRCUITS/ ISSUES

### 5.1 Typical Applications

The MCP1650/51/52/53 boost controller can be used in several different configurations and in many different applications. For applications that require minimum space, low cost and high efficiency, the MCP1650/51/52/53 product family is a good choice. It can be used in boost, buck-boost, Single-Ended Primary Inductive Converters (SEPIC), as well as in flyback converter topologies.

## 5.1.1 NON-BOOTSTRAP BOOST APPLICATIONS

Non-bootstrap applications are typically used when the output voltage is boosted to a voltage that is higher than the rated voltage of the MCP1650/51/52/53. For non-bootstrap applications, the input voltage is connected to the boost inductor through the optional current sense resistor and the V<sub>IN</sub> pin of the MCP1650/51/52/53. For this type of application, the S-option devices (UVLO at 2.55V, typical) should be used. The gated oscillator duty cycle will be dependant on the value of the voltage on V<sub>IN</sub>. If V<sub>IN</sub> > 3.8V, the duty cycle will be 56%. If V<sub>IN</sub> < 3.8V, the duty cycle will be 80%.

In non-bootstrap applications, output voltages of over 100V can be generated. Even though the MCP1650/51/52/53 device is not connected to the high boost output voltage, the drain of the external MOSFET and reverse voltage of the external Schottky diode are connected. The output voltage capacitor must also be rated for the output voltage.

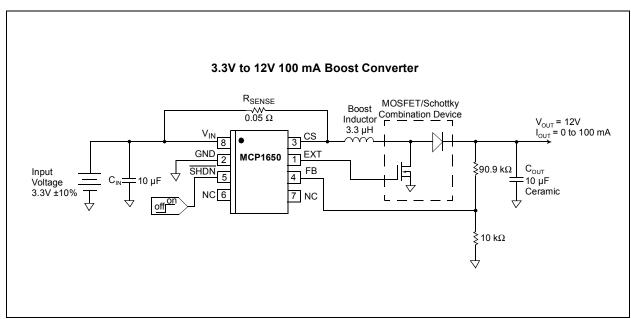


FIGURE 5-1: Typical Non-Bootstrap Application Circuit (MCP1650/51/52/53).

## 5.1.2 BOOTSTRAP BOOST APPLICATIONS

For bootstrap configurations, the higher-regulated boost output voltage is used to power the MCP1650/51/52/53. This provides a constant higher voltage used to drive the external MOSFET. The R-option devices (UVLO < 2.0V) can be used for applications that need

to start up with the input voltage below 2.7V. For this type of application, the MCP1650/51/52/53 will start off of the lower 2.0V input and begin to boost the output up to its regulated value. As the output rises, so does the input voltage of the MCP1650/51/52/53. This provides a solution for 2-cell alkaline inputs for output voltages that are less than 6V.

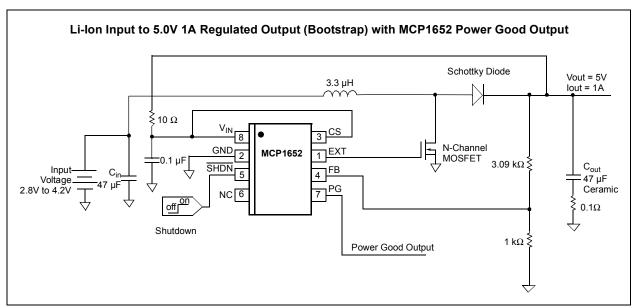


FIGURE 5-2: Bootstrap Application Circuit MCP1650/51/52/53.

## 5.1.3 SEPIC CONVERTER APPLICATIONS

In many applications, the input voltage can vary above and below the regulated output voltage. A standard boost converter cannot be used when the output voltage is below the input voltage. In this case, the MCP1650/51/52/53 can be used as a SEPIC controller. A SEPIC requires 2 inductors or a single coupled inductor, in addition to an AC coupling capacitor. As

with the previous boost-converter applications, the SEPIC converter can be used in either a bootstrap or non-bootstrap configuration. The SEPIC converter can be a very popular topology for driving high-power LEDs. For many LEDs, the forward voltage drop is approximately 3.6V, which is between the maximum and minimum voltage range of a single-cell Li-lon battery, as well as 3 alkaline or nickel metal batteries.

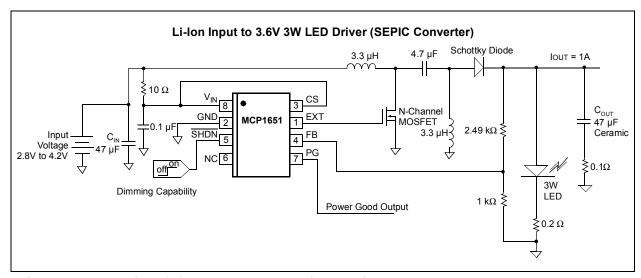


FIGURE 5-3: SEPIC Converter Application Circuit MCP1650/51/52/53.

#### 5.2 Design Considerations

When developing switching power converter circuits, there are numerous things to consider and the MCP1650/51/52/53 family is no exception. The gated oscillator architecture does provide a simple control approach so that stabilizing the regulator output is an easier task than that of a fixed-frequency regulator.

The MCP1650/51/52/53 controller utilizes an external switch and diode allowing for a very wide range of conversion (high voltage gain and/or high current gain).

There are practical, as well as power-conversion, topology limitations. The MCP1650/51/52/53 gated oscillator hysteretic mode converter has similar limitations, as do fixed-frequency boost converters.

#### 5.2.1 DESIGN EXAMPLE

Input Voltage = 2.8V to 4.2V

Output Voltage = 12V Output Current = 100 mA

Oscillator Frequency = 750 kHz

Duty cycle = 80% for  $V_{IN} < 3.8V$ Duty cycle = 56% for  $V_{IN} > 3.8V$ 

Setting the output voltage:

$$R_{TOP} = R_{BOT} \times \left( \left( \frac{V_{OUT}}{V_{FR}} \right) - 1 \right)$$

Where:

 $R_{TOP}$  = Top Resistor Value  $R_{BOT}$  = Bottom Resistor Value

By adjusting the external resistor divider, the output voltage of the boost converter can be set to the desired value. Due to the RC delay caused by the resistor divider and the device input capacitance, resistor values greater than 100 k $\Omega$  are not recommended. The feedback voltage is typically 1.22V.

For this example:

 $R_{BOT} = 10 k\Omega$ 

 $V_{OUT} = 12V$ 

 $V_{FB} = 1.22V$ 

 $R_{TOP} = 88.4 \text{ k}\Omega$ 

90.9  $K\Omega$  was selected as the closest standard value.

#### 5.2.1.1 Calculations

$$P_{OUT} = V_{OUT} \times I_{OUT}$$

Where:

 $P_{OUT}$  = 12V X 100 mA  $P_{OUT}$  = 1.2 Watts

$$P_{IN} = P_{OUT} / (Efficiency)$$

Where:

 $P_{IN} = 1.2W/80\%$ 

(80% is a good efficiency estimate)

 $P_{IN}$  = 1.5 Watts

For gated oscillator hysteretic designs, the switching frequency is not constant and will gate several pulses to raise the output voltage. Once the upper hysteresis threshold is reached, the gated pulses stop and the output will coast down at a rate determined by the output capacitor and the load. Using the gated oscillator switching frequency and duty cycle, it is possible to determine what the maximum boost ratio is for continuous inductor current operation.

$$V_{OUT} = \left(\frac{1}{I - D}\right) \times V_{IN}$$

This relationship assumes that the output load current is significant and the boost converter is operating in Continuous Inductor Current mode. If the load is very light or a small boost inductance is used, higher boost ratio's can be achieved.

Calculate at minimum VIN:

$$V_{OUTMAX} = \left(\frac{1}{1 - 0.8}\right) \times 2.8$$

The ideal maximum output voltage is 14V. The actual measured result will be less due to the forward voltage drop in the boost diode, as well as other circuit losses.

For applications where the input voltage is above and below 3.8V, another point must be checked to determine the maximum boost ratio. At 3.8V, the duty cycle changes from 80% to 56% to minimize the peak current in the inductor.

$$V_{OUTMAX} = \left(\frac{1}{I-0.56}\right) \times 3.8$$

For this case,  $V_{OUTMAX}$  = 8.63V less than the required 12V output specified. The size of the inductor has to decrease in order to operate the boost regulator in Discontinuous Inductor Current mode.

To determine the maximum inductance for Discontinuous Operating mode, multiply the energy going into the inductor every switching cycle by the number of cycles per second (switching frequency). This number must be greater than the maximum input power.

The equation for the energy flowing into the inductor is given below. The input power to the system is equal to energy times time.

$$Energy = \frac{1}{2} \times L \times I_{PK}^2$$

The inductor peak current is calculated using the equation below:

$$I_{PK} = \frac{V_{IN}}{L} \times T_{ON}$$

Using a typical inductance of 3.3  $\mu H$ , the peak current in the inductor is calculated below:

 $F_{SW} = 750 \text{ kHz}$ 

 $T_{ON} = (1/F_{SW} * Duty Cycle)$ 

 $I_{PK}(2.8V) = 905 \text{ mA}$ 

Energy (2.8V) =  $1.35 \mu$ -Joules

Power (2.8V) = 1.01 Watts

At 3.8V and below, the converter can boost to 14V while operating in the Continuous mode.

 $I_{PK}$  (3.8V) = 860 mA

Energy at 3.8V =  $1.22 \mu$ -Joules

Power = 0.914 Watts

For this example, a  $3.3 \,\mu H$  inductor is too large, a  $2.2 \,\mu H$  inductor is selected.

 $F_{SW} = 750 \text{ kHz}$ 

 $T_{ON} = (1/F_{SW} * Duty Cycle)$ 

 $I_{PK}(2.8V) = 1.36A$ 

Energy (2.8V) =  $2.02 \mu$ -Joules

Power (2.8V) = 1.52 Watts

 $I_{PK}(3.8V) = 1.29A$ 

Energy at 3.8V =  $1.83 \mu$ -Joules

Power = 1.4 Watts

As the inductance is lowered, the peak current drawn from the input at all loads is increased. The best choice of inductance for high boost ratios is the maximum inductance value necessary while maintaining discontinuous operation.

For lower boost-ratio applications (3.3V to 5.0V), a 3.3  $\mu H$  inductor or larger is recommended. In these cases, the inductor operates in Continuous Current mode.

#### 5.2.2 MOSFET SELECTION

There are a couple of key consideration's when selecting the proper MOSFET for the boost design. A low  $R_{DSON}$  logic-level N-channel MOSFET is recommended.

#### 5.2.2.1 MOSFET Selection Process.

- Voltage Rating The MOSFET drain-to-source voltage must be rated for a minimum of V<sub>OUT</sub> + V<sub>FD</sub> of the external boost diode. For example, in the 12V output converter, a MOSFET drain-tosource voltage rating of 12V + 0.5V is necessary. Typically, a 20V part can be used for 12V outputs.
- Logic-Level R<sub>DSON</sub> The MOSFET carries significant current during the boost cycle on time. During this time, the peak current in the MOSFET can get quite high. In this example, a SOT-23 MOSFET was used with the following ratings:

IRLM2502 N-channel MOSFET

 $V_{BDS}$  = 20V (Drain Source Breakdown

Voltage)

 $R_{DSON} = 50 \text{ milli-ohms} (V_{GS} = 2.5V)$ 

 $R_{DSON} = 35 \text{ milli-ohms} (V_{GS} = 5.0 \text{V})$ 

Q<sub>G</sub> = Total Gate Charge = 8 nC

V<sub>GS</sub> = 0.6V to 1.2V (Gate Source Threshold Voltage)

Selecting MOSFETs with lower  $R_{DSON}$  is not always better or more efficient. Lower  $R_{DSON}$  typically results in higher total gate charge and input capacitance, slowing the transition time of the MOSFET and resulting in increased switching losses.

#### 5.2.3 DIODE SELECTION

The external boost diode also switches on and off at the switching frequency and requires very fast turn-on and turn-off times. For most applications, Schottky diodes are recommended. The voltage rating of the Schottky diode must be rated for maximum boost output voltage. For example, 12V output boost converter, the diode should be rated for 12V plus margin. A 20V or 30V Schottky diode is recommended for a 12V output application. Schottky diodes also have low forward-drop characteristics, another desired feature for switching power supply applications.

## 5.2.4 INPUT/OUTPUT CAPACITOR SELECTION

There are no special requirements on the input or output capacitor. For most applications, ceramic capacitors or low effective series resistance (ESR) tantalum capacitors will provide lower output ripple voltage than aluminum electrolytic. Care must be taken not to exceed the manufacturer's rated voltage or ripple current specifications. Low-value capacitors are desired because of cost and size, but typically result in higher output ripple voltage.

The input capacitor size is dependant on the source impedance of the application. The hysteretic architecture of the MCP1650/51/52/53 boost converter can draw relatively high input current peaks at certain line and load conditions. Small input capacitors can produce a large ripple voltage at the input of the converter, resulting in unsatisfactory performance.

The output capacitor plays a very important role in the performance of the hysteretic gated oscillator converter. In some cases, using ceramic capacitors can result in higher output ripple voltage. This is a result of the low ESR that ceramic capacitors exhibit. As shown in the application schematics, 100 milli-ohms of ESR in series with the ceramic capacitor will actually reduce the output ripple voltage and peak input currents for some applications. The selection of the capacitor and ESR will largely determine the output ripple voltage.

#### 5.2.5 LOW BATTERY DETECTION

For low battery detection, the MCP1651 or MCP1653 device should be used. The low-battery detect feature compares the low battery input (LBI) pin to the internal 1.22V reference. If the LBI input is below the LBI threshold voltage, the low battery output (LBO) pin will sink current (up to 10 mA) through the internal opendrain MOSFET. If the LBI input voltage is above the LBI threshold, the  $\overline{\text{LBO}}$  output pin will be open or high impedance.

#### 5.2.6 POWER GOOD OUTPUT

For power good detection, the MCP1652 or MCP1653 device is ideal. The power good feature compares the voltage on FB pin to the internal reference ( $\pm 15\%$ ). If the FB pin is more than 15% above or below the power good threshold, the PG output will sink current through the internal open-drain MOSFET. If the output of the regulator is within  $\pm 15\%$  of the output voltage, the PG pin will be open or high-impedance.

## 5.2.7 EXTERNAL COMPONENT MANUFACTURES

Inductors:

Sumida<sup>®</sup> http://www.sumida.com/

Corporation

Coilcraft® http://www.coilcraft.com

BH Electronics® http://www.bhelectronics.com

Pulse http://www.pulseeng.com/

 $\mathsf{Engineering}^{\mathbb{R}}$ 

Coiltronics<sup>®</sup> http://www.cooperet.com/

Capacitors

MuRata<sup>®</sup> http://www.murata.com/
Kemet<sup>®</sup> http://www.kemet.com/
Taiyo-Yuden http://www.taiyo-yuden.com/

AVX<sup>®</sup> http://www.avx.com/

#### **MOSFETs and Diodes:**

International http://www.irf.com/

Rectifier

Vishay®/Siliconix http://www.vishay.com/com-

pany/brands/siliconix/ http://www.onsemi.com/

ON Semiconductor<sup>®</sup>

Fairchild http://www.fairchildsemi.com/

Semiconductor®

#### 6.0 TYPICAL LAYOUT

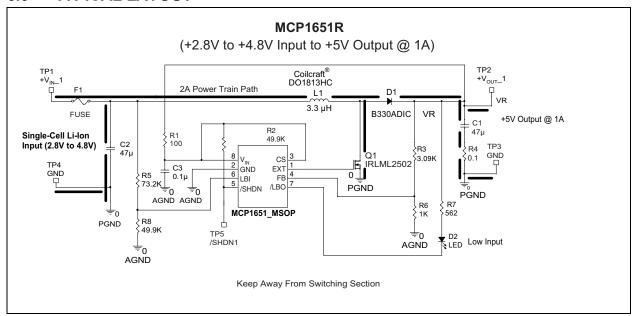


FIGURE 6-1: MCP1650/51/52/53 Application Schematic.

When designing the physical layout for the MCP1650/51/52/53, the highest priority should be placing the boost power train components in order to minimize the size of the high current paths. It is also important to provide ground-path separation between the large-signal power train ground and the small signal feedback path and feature grounds. In some cases, additional filtering on the  $V_{\mbox{\scriptsize IN}}$  pin is helpful to minimize MCP1650/51/52/53 input noise.

In this layout example, the critical power train paths are from input to output,  $+\mbox{$V_{IN}$}\!\!-\!\!1$  to  $\mbox{$F_1$}$  to  $\mbox{$C_2$}$  to  $\mbox{$L_1$}$  to  $\mbox{$Q_1$}$  to GND. Current will flow in this path when the switch  $(\mbox{$Q_1$})$  is turned on. When  $\mbox{$Q_1$}$  is turned off, the path for current flow will quickly change to  $+\mbox{$V_{IN}$}\!\!-\!\!1$  to  $\mbox{$F_1$}$  to  $\mbox{$L_1$}$  to  $\mbox{$D_1$}$  to  $\mbox{$C_1$}$  to R4 to GND. When starting the layout for this application, both of these power train paths should be as short as possible. The  $\mbox{$C_2$}$  ,  $\mbox{$Q_1$}$  and  $\mbox{$R_4$}$  GND connections should all be connected to a single "Power Ground" plane to minimize any wiring inductance.

Bold traces are used to represent high-current connections and should be made as wide as is practical.

 $\rm R_1$  and  $\rm C_3$  is an optional filter that reduces the switching noise on the  $\rm V_{IN}$  pin of the MCP1650/51/52/53. This should be considered for high-power applications (> 1W) and bootstrap applications where  $\rm V_{IN}$  of the MCP1650/51/52/53 is supplied by the output voltage of the boost regulator.

The feedback resistor divider that sets the output voltage should be considered sensitive and be routed away from the power-switching components discussed previously.

As shown in the diagram,  $R_6$ ,  $R_8$  and the GND pin of the MCP1650/51/52/53 should be returned to an analog ground plane.

The analog ground plane and power ground plane should be connected at a single point close to the input capacitor  $(C_2)$ .

Figure 6-2 represents the top wiring for the MCP1650/51/52/53 application shown.

As shown in Figure 6-2, the high-current wiring is short and wide. In this example, a 1 oz. copper layer is used for both the top and bottom layers. The ground plane connected to C2 and R4 are connected through the vias (holes) connecting the top and bottom layer. The feedback signal (from TP2) is wired from the output of the regulator around the high current switching section to the feedback voltage divider and to the FB pin of the MCP1650/51/52/53.

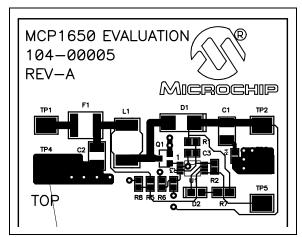


FIGURE 6-2: Top Layer Wiring.

Figure 6-3 represents the bottom wiring for the MCP1650/51/52/53 application shown.

Silk-screen reference designator labels are transparent from the top of the board. The analog ground plane and power ground plane are connected near the ground connection of the input capacitor (C<sub>2</sub>). This prevents high-power, ground-circulating currents from flowing through the analog ground plane.

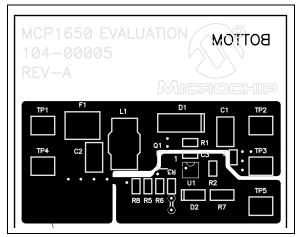
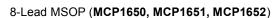


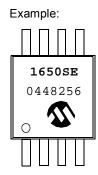
FIGURE 6-3: Bottom Layer Wiring.

#### 7.0 PACKAGING INFORMATION

### 7.1 Package Marking Information

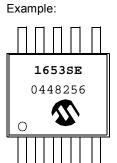






10-Lead MSOP (MCP1653)





**Legend:** XX...X Customer specific information\*

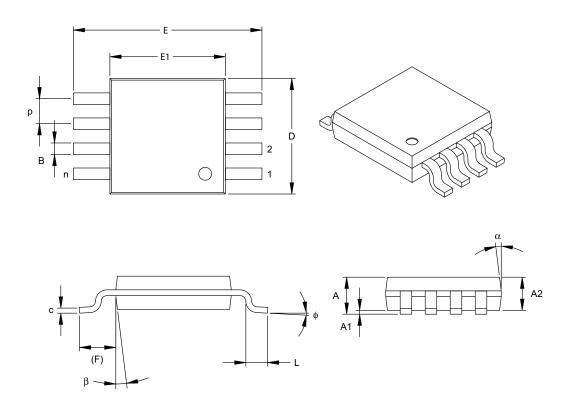
YY Year code (last 2 digits of calendar year)
WW Week code (week of January 1 is week '01')

NNN Alphanumeric traceability code

**Note**: In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line thus limiting the number of available characters for customer specific information.

\* Standard marking consists of Microchip part number, year code, week code, and traceability code.

## 8-Lead Plastic Micro Small Outline Package (UA) (MSOP)



	Units		INCHES		MILLIMETERS*		
Dimension Lim	iits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		8			8	
Pitch	р		.026 BSC		0.65 BSC		
Overall Height	Α	-	-	.043	-	-	1.10
Molded Package Thickness	A2	.030	.033	.037	0.75	0.85	0.95
Standoff	A1	.000	-	.006	0.00	-	0.15
Overall Width	E		.193 TYP.		4.90 BSC		
Molded Package Width	E1		.118 BSC		3.00 BSC		
Overall Length	D		.118 BSC		3.00 BSC		
Foot Length	L	.016	.024	.031	0.40	0.60	0.80
Footprint (Reference)	F		.037 REF		0.95 REF		
Foot Angle	ф	0°	-	8°	0°	-	8°
Lead Thickness	С	.003	.006	.009	0.08	-	0.23
Lead Width	В	.009	.012	.016	0.22	-	0.40
Mold Draft Angle Top	α	5°	-	15°	5°	-	15°
Mold Draft Angle Bottom	β	5°	-	15°	5°	-	15°

<sup>\*</sup>Controlling Parameter

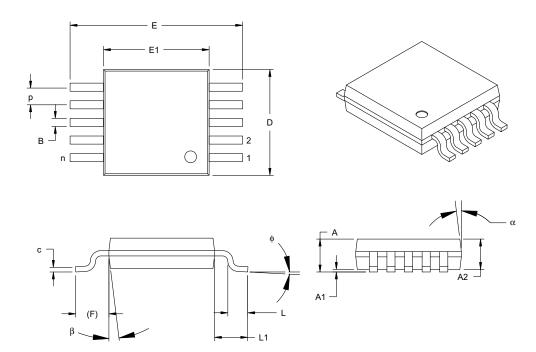
Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side.

JEDEC Equivalent: MO-187

Drawing No. C04-111

## 10-Lead Plastic Micro Small Outline Package (UN) (MSOP)



	Units	INCHES			MILLIMETERS*			
Dimension L	imits	MIN	NOM	MAX	MIN	NOM	MAX	
Number of Pins	n		10			10		
Pitch	р		.020 TYP			0.50 TYP.		
Overall Height	А	-	-	.043	-	-	1.10	
Molded Package Thickness	A2	.030	.033	.037	0.75	0.85	0.95	
Standoff	A1	.000	-	.006	0.00	-	0.15	
Overall Width	E		.193 BSC		4.90 BSC			
Molded Package Width	E1		.118 BSC		3.00 BSC			
Overall Length	D		.118 BSC		3.00 BSC			
Foot Length	L	.016	.024	.031	0.40	0.60	0.80	
Footprint	F		.037 REF		0.95 REF			
Foot Angle	ф	0°	-	8°	0°	-	8°	
Lead Thickness	С	.003	-	.009	0.08	-	0.23	
Lead Width	В	.006	.009	.012	0.15	0.23	0.30	
Mold Draft Angle Top	α	5°	-	15°	5°	-	15°	
Mold Draft Angle Bottom	β	5°	-	15°	5°	-	15°	

\*Controlling Parameter

Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side.

JEDEC Equivalent: MO-187

Drawing No. C04-021

### PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

PART NO. X	<u> </u>	Exa	Examples:				
Device UVI Optic	 LO Temperature Package	a) b) c)	MCP1650R-E/MS: MCP1650RT-E/MS: MCP1650S-E/MS:	2.0V Option 2.0V Option, Tape and Reel 2.55V Option			
Device	MCP1650: 750 kHz Boost Controller MCP1651: 750 kHz Boost Controller	d)	MCP1650ST-E/MS:	2.55V Option, Tape and Reel			
	MCP1652: 750 kHz Boost Controller	a)	MCP1651R-E/MS:	2.0V Option			
	MCP1653: 750 kHz Boost Controller	b)	MCP1651RT-E/MS:	2.0V Option, Tape and Reel			
		c)	MCP1651S-E/MS:	2.55V Option			
UVLO Options	R = 2.0V S = 2.55V	d)	MCP1651ST-E/MS:	2.55V Option, Tape and Reel			
Temperature Range	$E = -40^{\circ}C \text{ to } +125^{\circ}C$	a) b)	MCP1652R-E/MS: MCP1652RT-E/MS:	2.0V Option 2.0V Option, Tape and Reel			
Package	MS = Plastic Micro Small Outline (MSOP), 8-lead UN = Plastic Micro Small Outline (MSOP), 10-lead	c) d)	MCP1652S-E/MS: MCP1652ST-E/MS:	2.55V Option 2.55V Option, Tape and Reel			
		a) b)	MCP1653R-E/UN: MCP1653RT-E/UN:	2.0V Option 2.0V Option, Tape and Reel			
		c) d)	MCP1653S-E/UN: MCP1653ST-E/UN:	2.55V Option 2.55V Option, Tape and Reel			

### **Sales and Support**

#### Data Sheets

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NOTES:

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CERTIFIED BY DNV

ISO/TS 16949:2002

Microchip received ISO/TS-16949:2002 quality system certification for its worldwide headquarters, design and wafer fabrication facilities in Chandler and Tempe, Arizona and Mountain View, California in October 2003. The Company's quality system processes and procedures are for its PICmicro® 8-bit MCUs, KEELOQ® code hopping devices, Serial EEPROMs, microperipherals, nonvolatile memory and analog products. In addition, Microchip's quality system for the design and manufacture of development systems is ISO 9001:2000 certified.



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